Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/774,535	LEE ET AL.
Examiner	Art Unit
Leith A. Al-Nazer	2821

SEARCHED			
Class	Subclass	Date	Examiner
315	169.1- 169.4	4/13/2006	LA
313	498-505	4/13/2006	LA
345	77, 80	4/13/2006	LA
345	83, 204	4/13/2006	LA
345	690	4/13/2006	LA
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	-			

SEARCH NO (INCLUDING SEARCH	TES STRATEGY)
	DATE	EXMR
Updated EAST prior art text search (see "Examiner Search Notes")	4/13/2006	LA